Application/Control No. Applicant(s)/Patent Under Reexamination 09/786,063 HENNEN ET AL. Notice of References Cited Art Unit Examiner Page 1 of 1 2616 Bob A. Phunkulh **U.S. PATENT DOCUMENTS** Date Document Number Classification Name Country Code-Number-Kind Code MM-YYYY 370/503 07-2001 Kainulainen et al. US-6,262,996 Α 370/512 US-6,041,066 03-2000 Meki et al. В C US-5,706,291 01-1998 Kainulainen et al. 370/503 US-D US-Ε US-F US-G USн US-1 US-J US-Κ US-US-М FOREIGN PATENT DOCUMENTS Document Number Date Country Name Classification Country Code-Number-Kind Code MM-YYYY Ν 0 Ρ Q R S Т **NON-PATENT DOCUMENTS** Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages) U ٧ W

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